

State-of-the-art Fuel Cell Voltage Durability Status

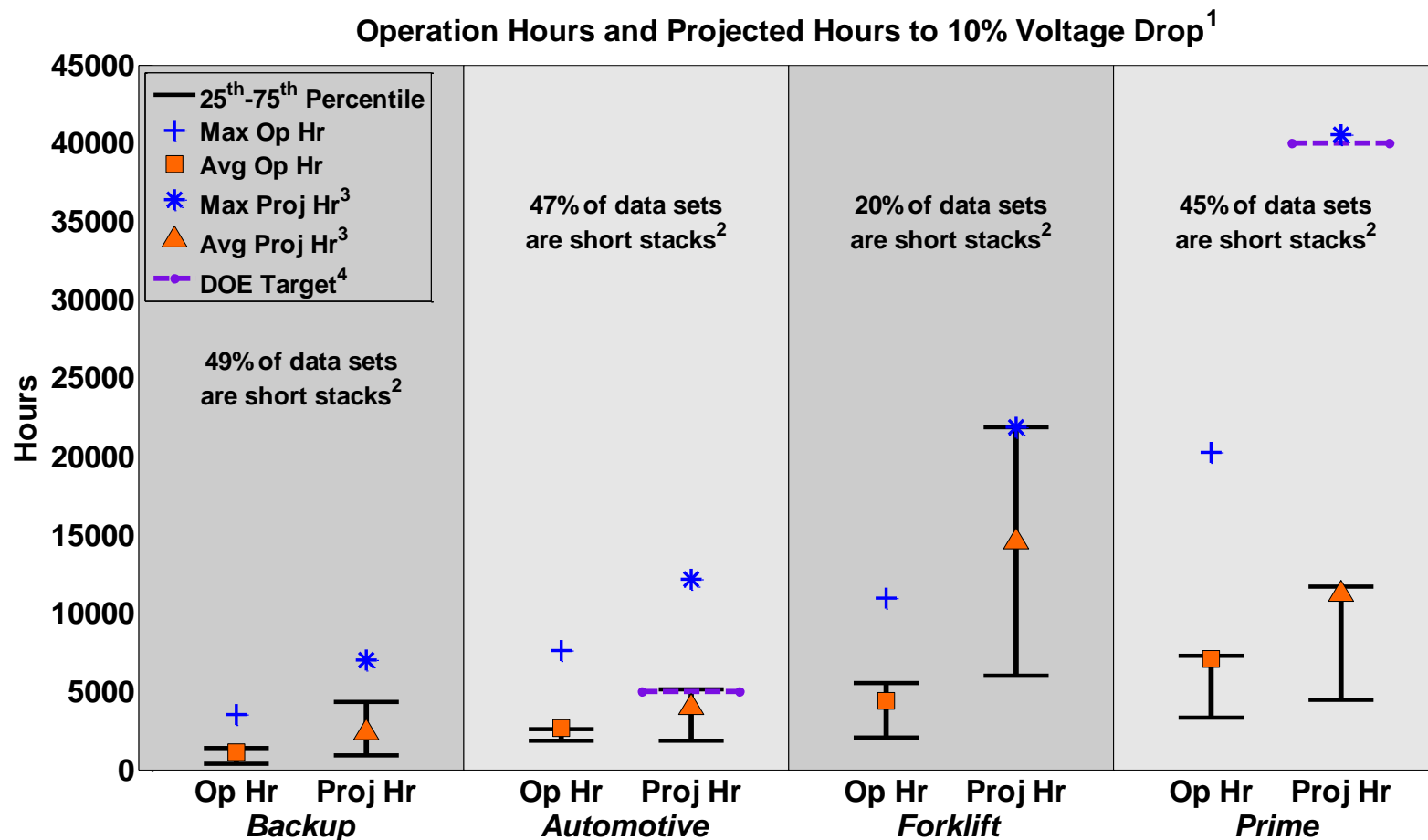


2012 Composite Data Products

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CDP#1: Lab Data Hours Accumulated and Projected Hours to 10% Stack Voltage Degradation



(1) At least 9 fuel cell developers supplied data. Analysis will be updated periodically.

(2) PEM & SOFC data from lab tested, full active area short stacks and systems with full stacks. Data generated from constant load, transient load, and accelerated testing between 2004 and early 2011.

(3) The DOE 10% voltage degradation metric is used for assessing voltage degradation; it may not be the same as end-of-life criteria and does not address catastrophic failure modes.

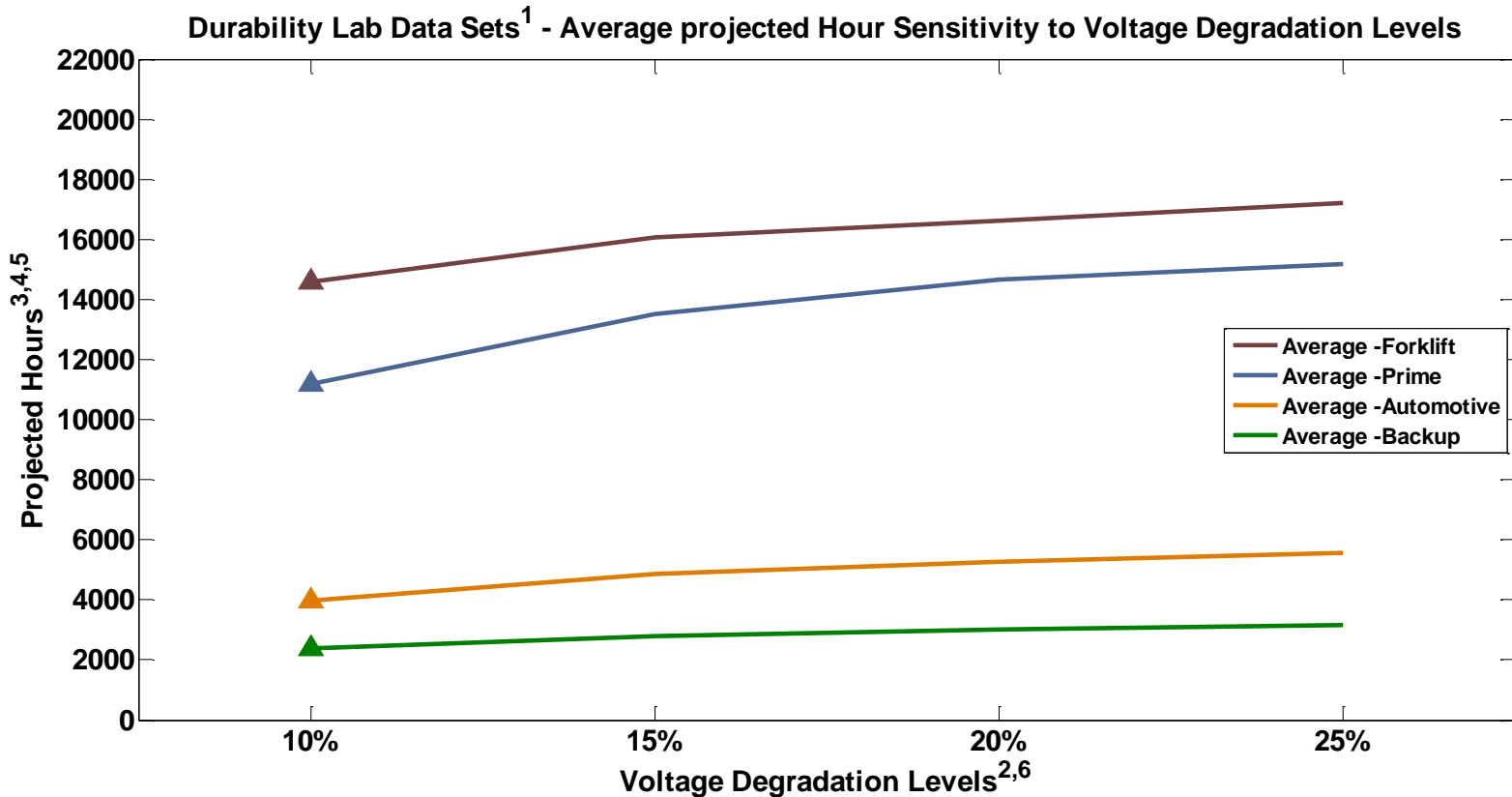
(4) DOE targets are for real-world applications; refer to Hydrogen, Fuel Cells, & Infrastructure Technologies Program Plan.



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CDP#2: Durability Lab Data Projection Sensitivity to Voltage Degradation Levels



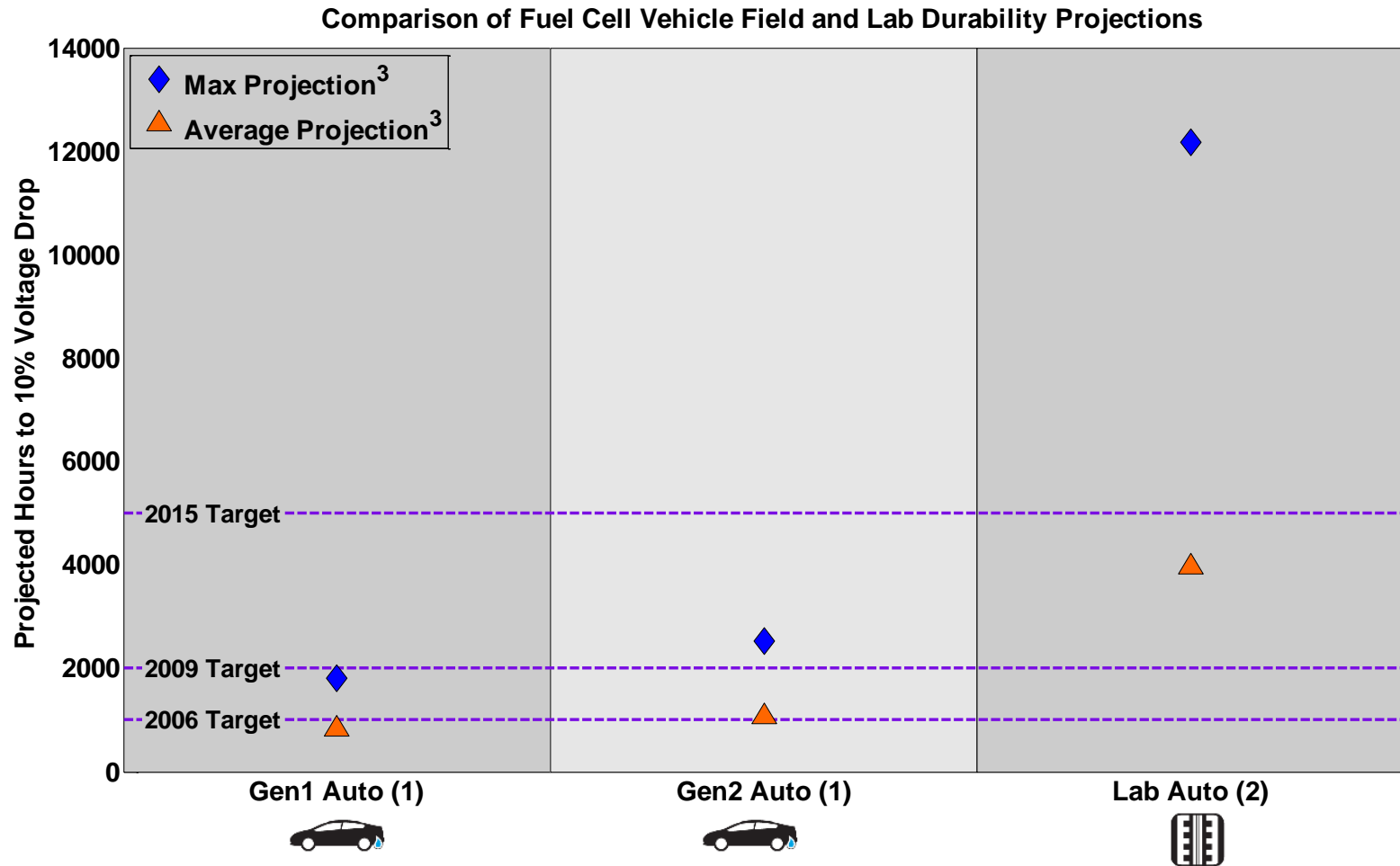
- (1) PEM & SOFC data from lab tested, full active area short stacks and systems with full stacks. Data generated from constant load, transient load, and accelerated testing between 2004 and 2011.
- (2) 10% Voltage degradation is a DOE metric for assessing fuel cell performance.
- (3) Curves generated using the average of each application at various voltage degradation levels.
- (4) The projection curves display the sensitivity to percentage of voltage degradation, but the projections do not imply that all stacks will (or do) operate at these voltage degradation levels.
- (5) Projections may be limited by demonstrated operation hours to minimize extrapolations.
- (6) The voltage degradation levels are not an indication of an OEM's end-of-life criteria and do not address catastrophic stack failures such as membrane failure.



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CDP#3: Field and Lab Durability Projection Comparison CDP for Automotive Category



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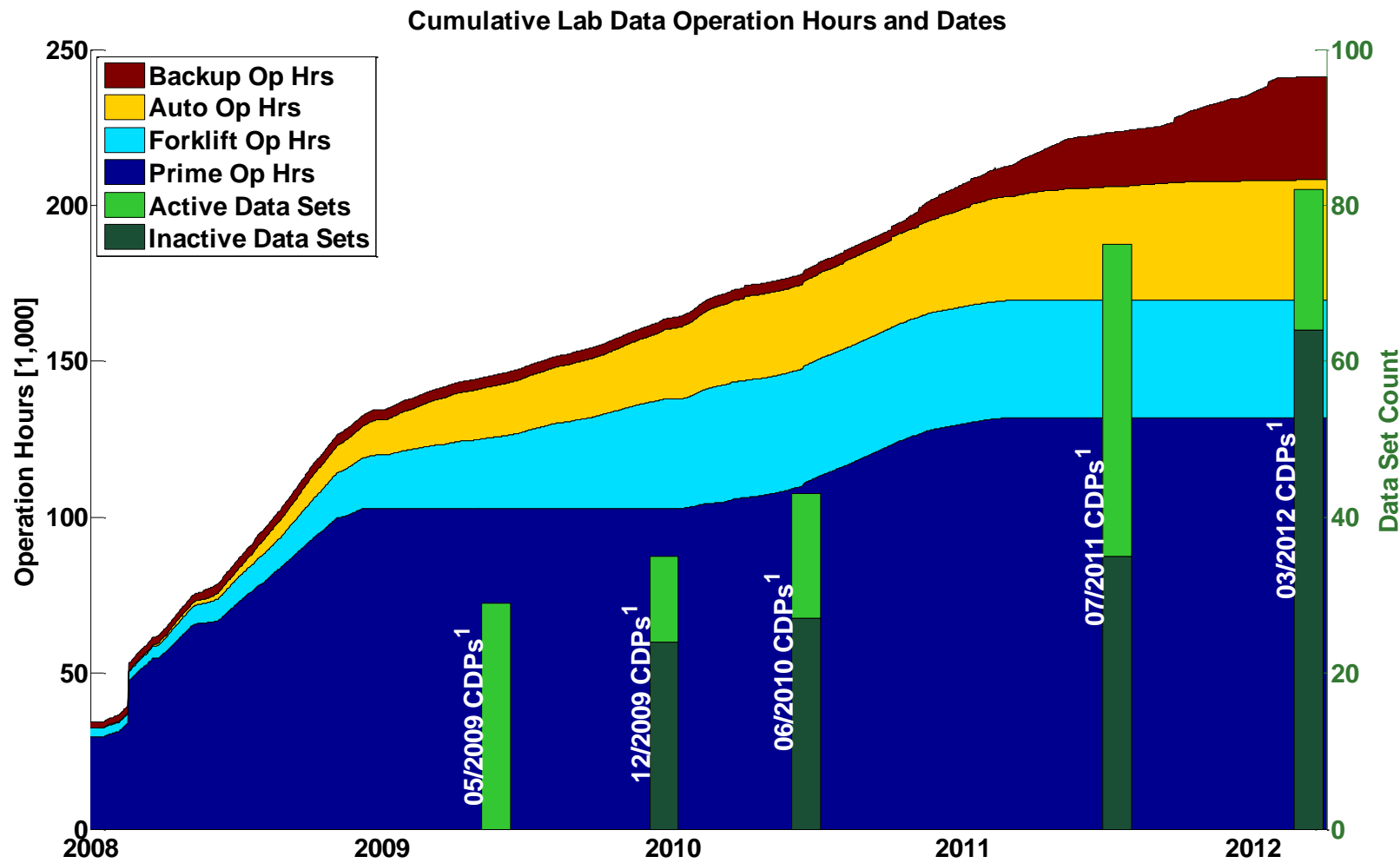
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(1) Gen1 and Gen2 Data from DOE's Learning Demonstration (2005 - 2010)

(2) Lab data providers may not be the same as participants in DOE's Learning Demonstration. 49% of data are full active area short stacks.

(3) The DOE 10% voltage degradation metric is used for assessing voltage degradation; it may not be the same as end-of-life criteria and does not address catastrophic failure modes.

CDP#4: Cumulative Operation Hours by Application and Number of Data Sets

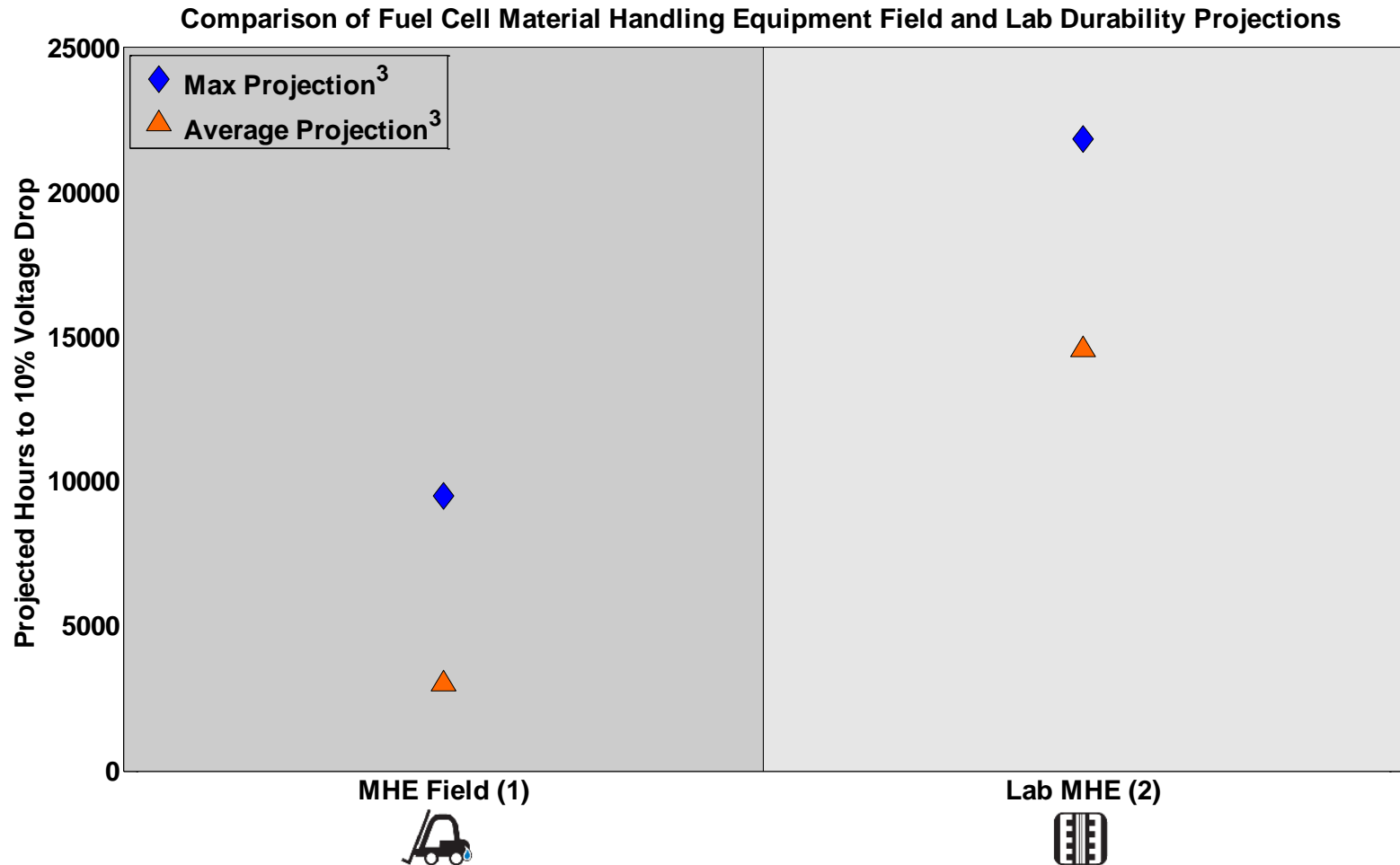


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1) Data set count at publication of a CDP set - where a data set represents a short stack, full stack, or system test data.

CDP#5: Field and Lab Durability Projection Comparison CDP for MHE Category



NREL cdp_lab_05

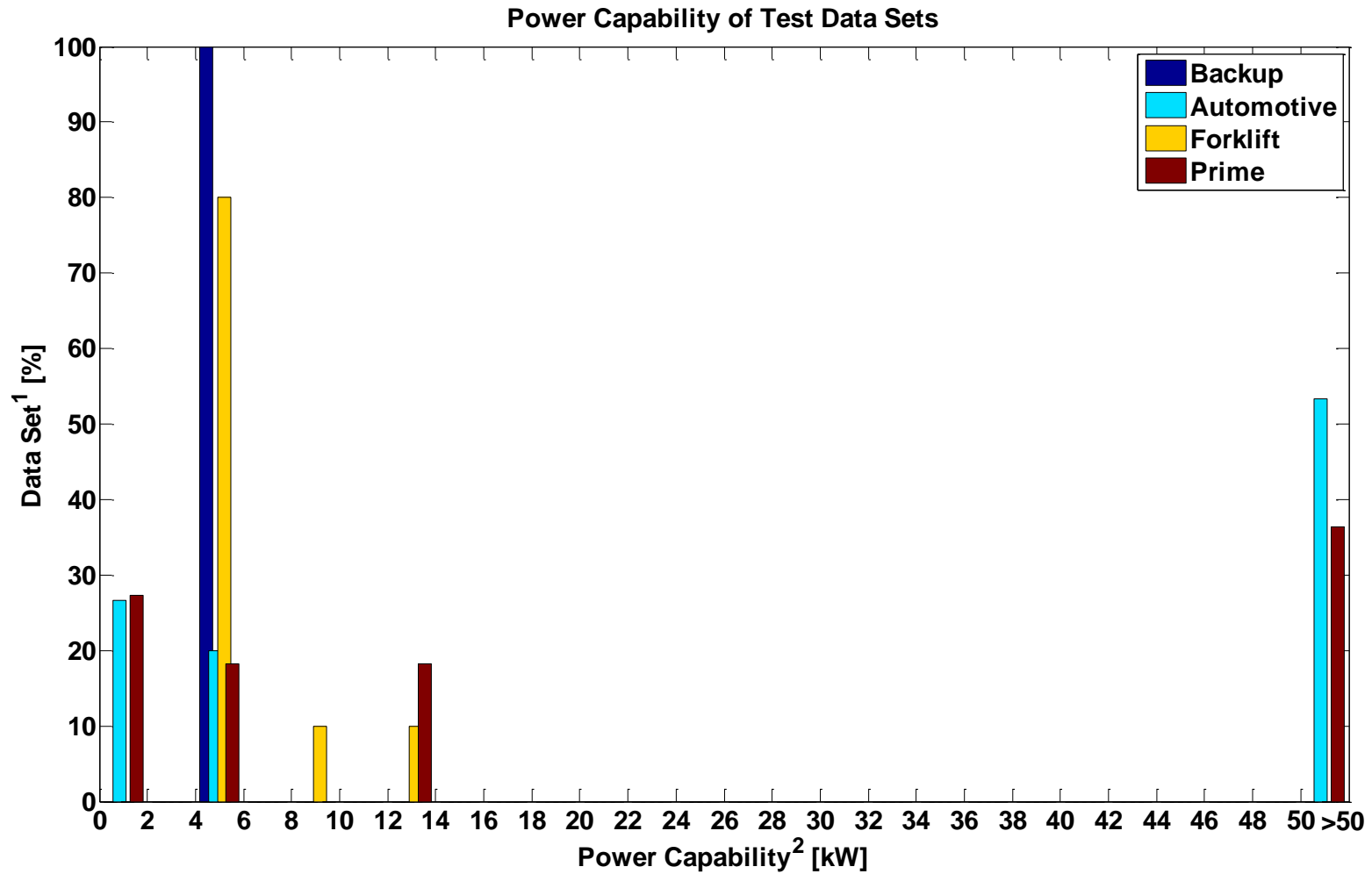
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(1) MHE Data from DOE's Early Market Demonstration (2009 -)

(2) Lab data providers may not be the same as participants in DOE's Field Demonstration. 20% of data are full active area short stacks.

(3) The DOE 10% voltage degradation metric is used for assessing voltage degradation; it may not be the same as end-of-life criteria and does not address catastrophic failure modes.

CDP#6: Data Set Power Capability



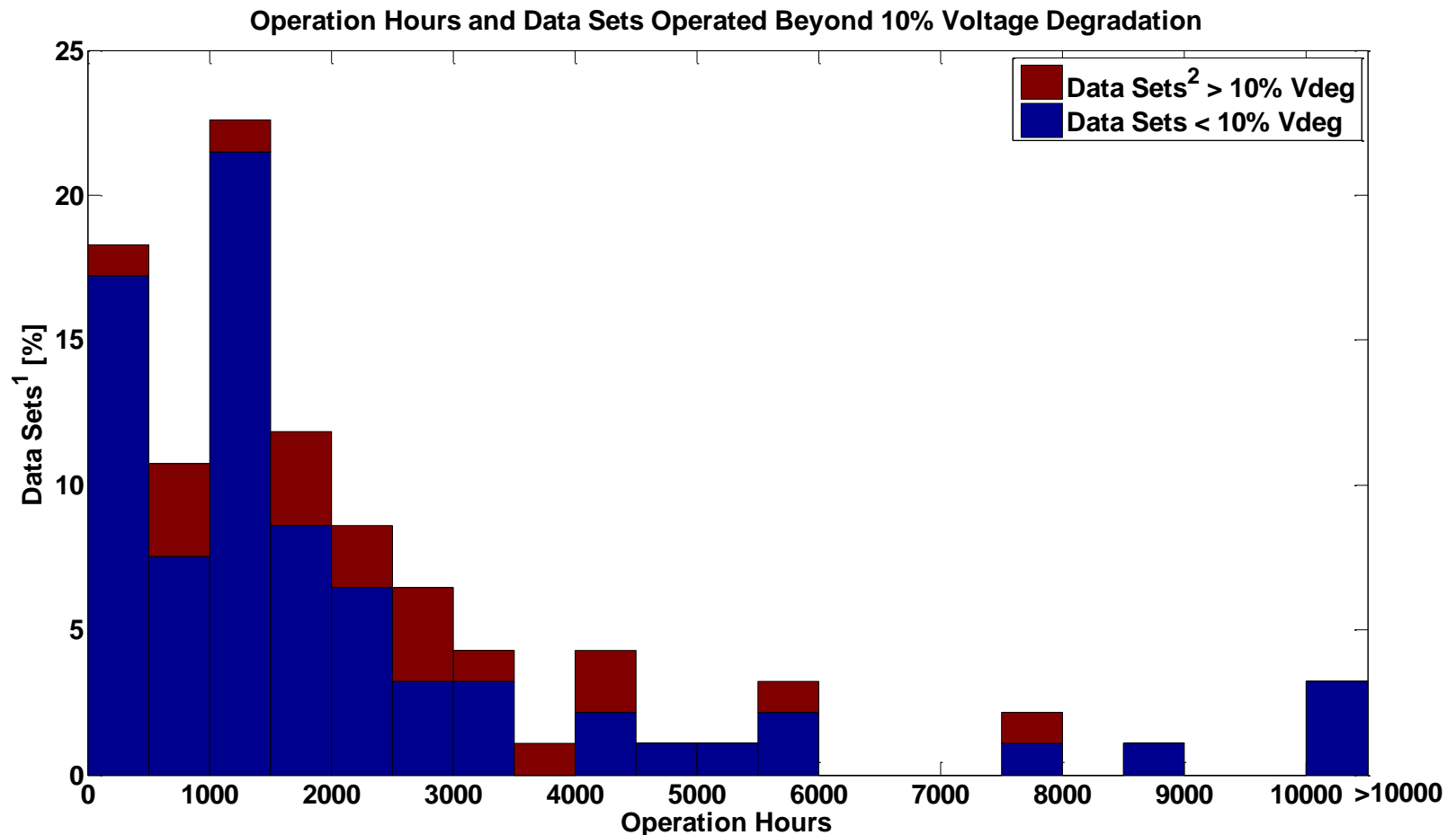
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1) A data set represents a short stack, full stack, or system test data.

2) Power capability represents the maximum power for a data set but not necessarily the load profile or time at a power level.

CDP#7: Data Set Operation Hours and the Percentage of Data Sets That Have Passed 10% Voltage Degradation



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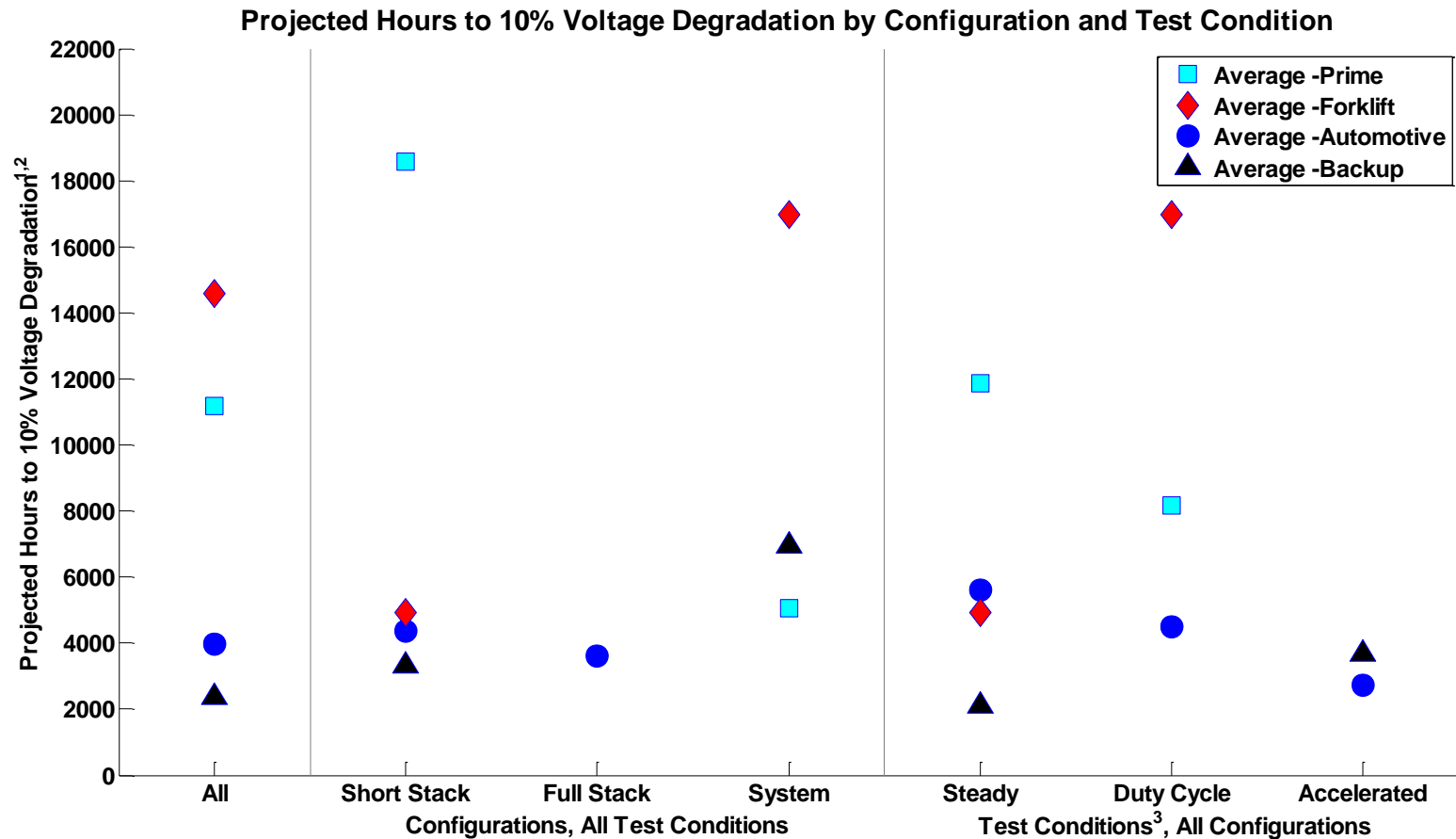
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1) A data set represents a short stack, full stack, or system test data.

2) The DOE 10% voltage degradation metric is used for assessing voltage degradation; it may not be the same as end-of-life criteria and does not address catastrophic failure modes.

Some data sets have operated beyond 10% voltage degradation because they are able to satisfy the operating requirements at a higher percentage of voltage degradation or the test is designed to operate until a failure.

CDP#8: Voltage Degradation by Configuration and Test Condition



- 1) The DOE 10% voltage degradation metric is used for assessing voltage degradation; it may not be the same as end-of-life criteria and does not address catastrophic failure modes.
- 2) Not all applications have data sets in each configuration or test condition group.
- 3) Steady - little or no change to load profile
Duty Cycle - load profile mimics real-world operating conditions
Accelerated - test profile is more aggressive than real-world operating conditions



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